

BAM contributions at:
EMAS 2015
14th European Workshop on MODERN DEVELOPMENTS AND
APPLICATIONS IN MICROBEAM ANALYSIS

03.-07.05.2015 at Portoroz, Slovenia

IMAGING OF SHAPE-ENGINEERED TiO₂ NANOPARTICLES BY HIGH-RESOLUTION SEM/EDX

E. Ortel^{1*}, L. Pellutiè², V. Maurino², J. Mielke¹, I. Häusler¹, W. Österle¹, V.-D. Hodoroaba¹

¹ BAM Federal Institute for Materials Research and Testing

² Università degli Studi di Torino

➤ presented as poster

DETERMINATION OF POROSITY OF HIGHLY POROUS THIN FILMS BY COMBINED SEM-EDS ANALYSIS

E. Ortel¹, R. Kraehnert², F. Galbert² and V.-D. Hodoroaba¹

¹ BAM Federal Institute for Materials Research and Testing

² Technical University of Berlin

➤ presented as a poster

➤ selected for oral presentation

(presented on the workshop)

➤ awarded with EMAS poster prize

Poster award



European Microbeam Analysis Society

14th European Workshop on Modern Developments and Applications in Microbeam Analysis
Grand Hotel Bernardin, Portorož, Slovenia, 3-7 May 2015

By Resolution of the International Scientific Committee of the EMAS 2015 Workshop

E. Ortel, R. Kraehnert, F. Galbert and V.-D. Hodoroaba

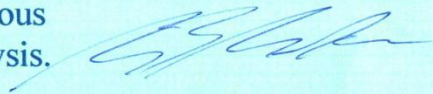
have been awarded the

2nd Prize

for their poster contribution entitled:

Determination of porosity of highly porous
thin films by combined SEM-EDS analysis.

May 2015


*EMAS President
Michael B. Matthews*